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	A	3,105,540	10/1963	Hardgrove		431	9			
	В	3,528,797	09/1970	Funk, et al.		71	39			~
	С	3,565,757	02/1971	Warshaw, et al.		23	2			
	D	3,773,897	11/1973	Fields, et al.		423	23:	5		
	Е	3,847,564	11/1974	Marion et al.		48	95			
	F	3,860,384	01/1975	Vulliet et al.		41	4			
	G	3,900,554	08/1975	Lyon		423	23:	5		
	H	3,970,739	07/1976	Shiraishi et al.		423	23	S		
	I	4,021,188	05/1977	Yamagishi et al.		431	158	3		
	J	4,029,752	06/1997	Cahn		423	563	3		
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	K	4,039,446	08/1997	Ban et al.		210	688		
	L	4,080,423	03/1978	Smith et al.		423	210		
	М	4,089,639	05/1978	Reed et al.		431	211		
	N	4,119,702	10/1978	Anuhata et al.		423	235		
	O	4,150,631	04/1979	Frey et al.		110	186		
	P	4,154,581	05/1979	Nack et al.		48	197R	_	
	o	4,173,454	11/1979	Heins		44	522	-	
	R	4,196,057	04/1980	May et al.		205	775.5	_	
	S	4,208,386	06/1980	Arand et al.		423	235		
	T	4,213,944	07/1980	Azuhata et al.		423	235		
	Ū	4,294,178	10/1981	Borio et al.		110	347		
	v	4,318,718	03/1993	Carver et al.		110	347		
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	W	4,325,924	04/1982	Arand et al.		423	23	5		
	X	4,375,949	03/1983	Salooja		431	17			
	Y	4,381,718	05/1993	Carver et al.		110	34	7		
	Z	4,469,050	09/1984	Korenberg		122	4D	,		
	AA	4,502,633	03/1985	Saxon		239	42			
	BB	4,504,211	03/1985	Beardmore		44	60			
	CC	4,506,608	03/1985	Strohmeyer, Jr.		110	24	5		****
	DD	4,507,075	03/1985	Buss et al.		431	111			
	EE	4,507,269	03/1985	Dean et al.		423	23:			
	FF	4,565,137	01/1986	Wright		110	26			
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	GG	4,584,948	04/1986	Syred et al.			110	26	4		
	HH	4,624,840	11/1986	Dean et al.			423	23:	5		
	II	4,627,965	12/1986	Hegemann et al.			423	24:	2		
	JJ	4,672,900	06/1987	Santalla et al.			431	9			
	KK	4,704,084	11/1987	Liu et al.			431	7			
	LL	4,751,065	06/1998	Bowers			423	23:	5		
	MM	4,777,024	10/1988	Epperly et al.			423	23:	5		
	NN	4,780,289	10/1988	Epperly et al.			423	23:	5		
	00	4,809,910	09/1998	Svendssen			110	23:	5		
	PP	4,824,441	04/1989	Kindig			44	604	4		
	QQ	4,842,834	06/1989	Burton			423	23:	5	1	
	RR	4,873,930	10/1989	Egnese et al.			110	34:	5		
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	SS	4,915,036	04/1990	DeVita		110	215				
	TT	4,927,612	05/1990	Bowers		423	235				
	UU	4,926,711	10/1990	Yamauchi et al.		110	347				
	VV	4,978,514	12/1990	Hofmann et al.		423	235				
	ww	4,985,218	01/1991	DeVita		423	235				
	XX	4,992,249	02/1991	Bowers		423	235				
	YY	5,017,347	05/1991	Epperly et al.		423	235				
	ZZ	5,032,154	07/1991	Wright		422	109				
	AAA	5,048,432	09/1991	Hogmann		110	345				
	BBB	5,052,921	10/1991	Hemsath		423	121				
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	CCC	5,057,293	05/1990	Epperly, et al.			423	235			
	DDD	5,105,747	04/1992	Khinkis et al.			110	345			
	EEE	5,139,754	08/1992	Luftglass et al.			423	235			
	FFF	5,146,858	09/1992	Tokuda et al.			110	261			
	GGG	5,240,404	08/1993	Hemsath et al.			431	9			
	ННН	5,261,602	11/1993	Brent et al.			239	132	.3		
	III	5,286,467	02/1994	Sun et al.			423	239	.1		
	JJJ	5,310,334	05/1994	Sprios			431	5			
	KKK	5,336,081	08/1994	Saito et al.			431	190		+	
	LLL	5,342,592	08/1994	Hoblyn et al.			423	235			
	MMM	5,345,883	09/1994	Panos			110	345		+	
	NNN	5,536,482	07/1996	Diep et al.			423	235			
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	000	5,489,419	02/1996	Diep et al.			423	235	5		
	PPP	5,585,081	12/1996	Chu et al.			423	239	9.1		
	QQQ	5,690,039	11/1997	Monroe et al.			110	264	1		
	RRR	5,707,596	01/1998	Lewandowski et al.			423	235	5	\top	
	SSS	5,728,357	03/1998	von Harpe			423	239			
	TTT	5,809,910	09/1998	Svendssen			110	235	5	_	
	UUU	5,853,684	12/1996	Fang et al.			423	239	0.1		
	VVV	5,854,173	12/1998	Chang et al.			502	417	Į.		
	www	6,019,068	02/2000	Tsuo et al.			122	4D			
	XXX	6,042,371	03/2000	Mitani et al.			431	215	5		
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	GGGG	7,335,014	02/2008	Higgins		431	4		
	нннн	2003/0011948	06/2003	Gaita et al.		96	108		
	IIII	2004/0045437	03/2004	Chang et al.		095	134		
	JJJJ	2004/0120872	06/2004	Fan et al.		423	239.1		
	KKKK	2004/0185399	09/2004	Moberg		431	4		
	LLLL	2004/0185402	09/2004	Moberg		431	9		
	MMM	2004/0185401	09/2004	Moberg		431	9		
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	PPPP	2005/0000901	01/2005	Campbell et al.		210	660		
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	QQQQ	2005/0002841	01/2005	Moberg		423	235	- 2	7770
	RRRR	2005/0013755	01/2005	Higgins		423	235		
	SSSS	6,953,494	10/2005	Nelson, Jr.		95	134		
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	YYYY	EP 0 326 943	01/1989	EPO				X	
	ZZZZ	GN 2 001 419	07/1978	UK				X	
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	EEEEE	Moberg, et al, pres	entation at P	owerGen Intl. 11/30-12/2/	99				
	EEEEE		his New NO	Control Technology Obs	olete SCR	.s?"; RM.	Corp., un	lated relate	ed
		technology							
EXAMINER				DATE	CONSID	ERED			
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				t citation is in conformanc			draw line t	rough cita	tion if not
in conformanc	e and not o	considered. Include	copy of this	form with next communic	ation to at	oplicant.			